

Gaussian processes for non-rigid registration

Connections to medical image analysis

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Aims of the talk

 Show how Analysis by Synthesis and Gaussian processes lead to a family of methods for non-rigid registration

 Provide an understanding of many common algorithms in terms of Gaussian processes

• Show how to derive new registration approaches using GPMMs and MCMC

Outline

- The registration problem
 - Problem formulation
 - Registration as analysis by synthesis problem
 - An algorithm using Gaussian process priors
- Priors for registration
 - Spline-based models, Radial basis functions
 - Multis-scale and Spatially-varying models
 - Statistical deformation models

- Likelihood functions
 - Landmark registration
 - Image to image registration
 - Surface to image registration

• Advancing registration

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• Some ideas where to go from here





Variational formulation

$$\varphi^* = \arg\min_{\varphi} D[I_R, I_T \circ \varphi] + \lambda R[\varphi]$$

Mapping φ^* is trade-off that

- makes the images look similar (for similarity measure *D*)
- matches the prior assumptions (encoded by regularizer R)

Variational formulation

$$\varphi^* = \arg\min_{\varphi} D[I_R, \varphi] + \lambda R[\phi]$$



Variational formulation

$$\varphi^* = \arg\min_{\varphi} D[I_R, I_{\varphi} \circ \varphi] + \lambda \varphi$$



Variational formulation

$$\varphi^* = \arg\min_{\varphi} D[I_R, I_T \circ \varphi] + \lambda R[\varphi]$$



Representation of the mapping φ





Representation of the mapping ϕ





Representation of the mapping ϕ



Assumption: Images are rigidly aligned

• Mapping can be represented as a displacement vector field:

$$\varphi(x) = x + u(x)$$
$$u : \Omega \to \mathbb{R}^d$$

Representation of the mapping arphi



Assumption: Images are rigidly aligned

 Mapping can be represented as a displacement vector field:

 $\varphi(x) = x + u(x)$ $u : \Omega \to \mathbb{R}^d$

Further assumption:

• φ is parametric : $\varphi[\theta](x) = x + u[\theta](x)$

Representation of the mapping arphi



Mapping: $\varphi[\theta](x) = x + u[\theta](x)$

Observation:

- Knowledge of θ and I_R allows us to synthesize target image I_T
 - (at least up to intensity differences)

Registration as analysis by synthesis



Probabilistic formulation of registration

Using Bayes rule:
$$P(\varphi[\theta]|I_T, I_R) = \frac{P(I_T|\varphi[\theta], I_R)P(\varphi[\theta], I_R)}{P(I_T)}$$

$$MAP \ solution \\ \theta^* = \arg \max_{\theta} p(\varphi[\theta]|I_T, I_R) = \arg \max_{\theta} p(\varphi[\theta]) p(I_T|I_R \circ \varphi[\theta])$$

Mapping θ^* is trade-off that defines a mapping $\varphi[\theta^*]$ which

- explains the data well (likelihood function)
- matches the prior assumptions (prior distribution)

Registration problem

 $\varphi^* = \arg \max_{\theta} p(\varphi[\theta]) p(I_T | I_R \circ \varphi[\theta])$ = $\arg \max_{\theta} \ln p(\varphi[\theta]) + \ln(p(I_T | I_R \circ \varphi[\theta]))$ = $\arg \min_{\theta} - \ln p(\varphi[\theta]) - \ln(p(I_T | I_R \circ \varphi[\theta]))$

Variational formulation

$$\varphi^* = \arg\min_{\varphi} D[I_T, I_R \circ \varphi] + \lambda R[\varphi]$$

Probabilistic formulation $\theta^* = \arg\min_{\theta} - \ln(p(I_T | I_R \circ \varphi[\theta])) - \ln p(\varphi[\theta])$

Take home message: Registration is model fitting!!!

Gaussian processes



Define the Gaussian process $u \sim GP(\mu, k)$ with mean function $\mu: \Omega \to \mathbb{R}^2$ and covariance function $k: \Omega \times \Omega \to \mathbb{R}^{2 \times 2}$.

Parametric representation of Gaussian process

Represent GP using only the first
$$r$$
 components of its KL-Expansion
 $u = \mu + \sum_{i=1}^{r} \alpha_i \sqrt{\lambda_i} \phi_i, \quad \alpha_i \sim N(0, 1)$

- We have a finite, parametric representation of the process.
- We know the pdf for a deformation *u*

$$p(u) = p(\alpha) = \prod_{i=1}^{r} \frac{1}{\sqrt{2\pi}} \exp(-\alpha_i^2/2) = \frac{1}{Z} \exp(-\frac{1}{2} \|\alpha\|^2)$$

Registration problem

$$\varphi^* = \arg\min_{\theta} - \ln p(\varphi[\theta]) - \ln p(I_T | I_R \circ \varphi[\theta])$$

$$= \arg\min_{\theta} - \ln \frac{1}{Z} \exp(-\frac{1}{2} ||\theta||^2) - \ln(p(I_T | I_R \circ \varphi[\theta]))$$

$$= \arg\min_{\theta} - \ln \frac{1}{Z} + \frac{1}{2} ||\theta||^2 - \ln(p(I_T | I_R \circ \varphi[\theta]))$$

$$= \arg\min_{\theta} \frac{1}{2} ||\theta||^2 - \ln(p(I_T | I_R \circ \varphi[\theta]))$$

Summary: registration problem

$$\arg\min_{\theta} \frac{1}{2} \|\theta\|^2 + \ln(p(I_T | I_R \circ \varphi[\theta]))$$

- Variational and probabilistic formulation are closely related
 - Prior can be seen as regularizer
 - Likelihood term is an image similarity
- For a low-rank Gaussian process prior, the problem becomes parametric since

$$\varphi[\theta](x) = x + \mu(x) + \sum_{i=1}^{\infty} \theta_i \sqrt{\lambda_i} \phi_i(x)$$

- Can be optimized using gradient-descent schemes.
- All the regularization assumptions are encoded in the eigenfunctions ϕ_i

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Why are priors interesting?

$$\theta^* = \arg \max_{\theta} p(\varphi[\theta]) p(I_T | I_R \circ \varphi[\theta])$$



Why are priors interesting?





Defining a Gaussian process

A Gaussian process $GP(\mu, k)$ is completely specified by a mean function μ and covariance function (or kernel) k.

- $\mu: \Omega \to \mathbb{R}^d$ defines how the average deformation looks like
- $k: \Omega \times \Omega \rightarrow \mathbb{R}^{d \times d}$ defines how it can deviate from the mean
 - Must be positive semi-definite

The mean function



• Usual assumption:

$$\mu(x) = \begin{pmatrix} \mu_1(x) \\ \vdots \\ \mu_d(x) \end{pmatrix} = \begin{pmatrix} 0 \\ \vdots \\ 0 \end{pmatrix}$$

• The reference shape is an average shape.

Scalar-valued Gaussian kernel



Diagonal kernel

$$k(x,x') = \begin{pmatrix} k^{(1)}(x,x') & \cdots & 0 \\ \vdots & \ddots & \vdots \\ 0 & \cdots & k^{(d)}(x,x') \end{pmatrix}$$

- $k^{(1)}, \dots, k^{(d)}: \mathcal{X} \times \mathcal{X} \to \mathbb{R}$ are scalar-valued kernels
- $k: \mathcal{X} \times \mathcal{X} \to \mathbb{R}^{d \times d}$ becomes a matrix valued kernel.

Assumption: Each dimension is modelled independently.

• the output-dimensions are uncorrelated.

A model for smooth 2D deformations

$$k(x, x') = \begin{pmatrix} s_1 \exp\left(-\frac{\|x - x'\|^2}{\sigma_1^2}\right) & 0\\ 0 & s_2 \exp\left(-\frac{\|x - x'\|^2}{\sigma_2^2}\right) \end{pmatrix}$$

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A model for smooth deformations



 $s_1 = s_2$ small, $\sigma_1 = \sigma_2$ large

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A model for smooth deformations



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A model for smooth deformations



 $s_1 = s_2$ large, $\sigma_1 = \sigma_2$ large

Matern class of kernels

$$k(x,x') = \sigma^2 \frac{2^{1-\nu}}{\Gamma(\nu)} \left(2\sqrt{2\nu} \frac{\|x-x'\|}{\rho} \right)^{\nu} K_{\nu}(\sqrt{2\nu} \frac{\|x-x'\|}{\rho})$$

- Γ is the Γ function, k_{ν} the modified Bessel function and ν , ρ are parameters
- The derivatives are $\nu 1$ times differentiable
- Special cases:

•
$$\nu = \frac{1}{2}$$
: $k(x, x') = \sigma^2 \exp(-\frac{\|x - x'\|}{\rho})$
• $\nu = \frac{3}{2}$: $k(x, x') = \sigma^2 (1 + \frac{\sqrt{3}\|x - x'\|}{\rho}) \exp(-\frac{\sqrt{3}\|x - x'\|}{\rho})$

• $\nu \rightarrow \infty$ Gaussian kernel

Thin-plate splines

• Minimize the bending energy of a metal sheet

$$R[\varphi] = \sum_{k=1}^{d} \int_{\Omega} \left(\nabla^{T} \nabla \varphi_{k}(x) \right)^{2} dx$$

• Corresponding covariance function

$$k(x, x') = \frac{1}{12} (2\|x - x'\|^3 - 3R(\|x - x'\|^2 + R^3))$$

where $R = \max_{x, x' \in \Omega} \|x - x'\|$

Rohr, Karl, et al. "Landmark-based elastic registration using approximating thin-plate splines." *IEEE Transactions on medical imaging* 20.6 (2001): 526-534.

Elastic body splines

- Mechanical model of an elastic body or material
- Solution to the following PDE

$$\mu \nabla^2 u(x) + (\mu + \lambda) \nabla [\nabla \cdot u(x)] = c |x|$$

• Corresponding (matrix-valued) covariance function (may not be positive definite) $k(x, x') = (12(1 - \nu) - 1)|x|^2 I - 3xx^T$ where $\nu = \frac{\lambda}{2(\lambda + \mu)}$

Kohlrausch, Jan, Karl Rohr, and H. Siegfried Stiehl. "A new class of elastic body splines for nonrigid registration of medical images." *Journal of Mathematical Imaging and Vision* 23.3 (2005): 253-280.

B-Splines

• Use B-Spline basis function

$$k(x,y) = \sum_{k \in \mathbb{Z}^d} \beta(sx - k)\beta(sy - k)$$

Where *s* is a scaling constant

- Rueckert, Daniel, et al. "Nonrigid registration using free-form deformations: application to breast MR images." *IEEE transactions on medical imaging* 18.8 (1999): 712-721.
- Klein, Stefan, et al. "Elastix: a toolbox for intensity-based medical image registration." *IEEE transactions on medical imaging* 29.1 (2010): 196-205.

Statistical deformation models

Estimate mean and covariance function from data:



Summary: Priors

- Leads to formulation of many standard transformation models in terms of Gaussian process
 - Improves understanding of methods
 - Let's us switch between "priors"

- Purely conceptual formulation
 - No algorithms
- Can sample and visualize deformations
 - Invaluable to check assumptions

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Landmark likelihood

For one landmark pair (l_R, l_T) :

 $p(l_T | \theta, l_R) = N(\varphi[\theta](l_R), \sigma^2)$

For many landmarks $L = ((l_R^1, l_T^1), \dots, (l_R^n, l_T^n))$

$$p(l_1^T, \dots, l_n^T | \theta, l_R^1, \dots, l_R^n)$$
$$= \prod_i N(\varphi[\theta](l_R), \sigma^2)$$



Landmark likelihood and GP Regression



Given:

- Gaussian process: $u \sim GP(\mu, k)$
- Observations: $\{(l_i^R, \tilde{u}_i), i = 1, ..., m\}$

Assume:

$$u(\tilde{x}_i) + \epsilon = \tilde{u}_i \text{ with } \epsilon \sim N(0, \sigma^2 I_{2 \times 2}).$$

Goal:

• Find posterior distribution $u \mid l_1^R, \dots, l_n^R, \tilde{u}_1, \dots, \tilde{u}_m$

Gaussian process regression

The posterior $u | l_1^R, ..., l_n^R, \tilde{u}_1, ..., \tilde{u}_m$ is a Gaussian process $GP(\mu_p, k_p)$ Its parameters are known analytically.

 $\mu_p(x) = \mu(x) + K(x, Y)(K(Y, Y) + \sigma^2 I_{2m \times 2m})^{-1}(\widetilde{u} - \mu(Y))$ $k_p(x, x') = k(x, x') - K(x, Y)(K(Y, Y) + \sigma^2 I_{2m \times 2m})^{-1}K(Y, x')$

Landmark registration





Landmark likelihood: Some remarks

- Classical problems in registration
- Needs either many landmark points or good structure of prior to achieve good results



Rohr, Karl, et al. "Landmark-based elastic registration using approximating thin-plate splines." *IEEE Transactions on medical imaging* 20.6 (2001): 526-534.

Image to image registration

• What is a good synthesis function?



Simple choice: Use the warped reference image!

 $I_R \circ h_{\theta}^{-1}$

Image likelihood (single point)

- Probabilistic model: $I_T(h_{\theta}(x)) = I_R(x) + \epsilon, \ \epsilon \sim N(0, \sigma^2), x \in \Omega_R$
- Likelihood for a single point *x*:

 $p(I_T(h_\theta(x))|\theta, I_R, x) \sim N(I_R(x), \sigma^2)$



Image likelihood (full image)

• Assuming that noise is independent at each point:

$$p(I_T \circ h_\theta \mid \vec{\theta}, I_R) \sim \prod_{x \in I_R} N(I_R(x), \sigma^2)$$
$$p(I_T \circ h_\theta \mid \vec{\theta}, I_R) = \frac{1}{Z} \prod_{x \in I_R} \exp(-\frac{\left(I_R(x) - I_T(h_\theta(x))\right)^2}{\sigma^2})$$

The sum of squared distance metric

$$\ln p(I_T \circ h_\theta \mid \vec{\theta}, I_R) = \ln \left[\frac{1}{Z} \prod_{x \in I_R} \exp\left(-\frac{\left(I_R(x) - I_T(h_\theta(x))\right)^2}{\sigma^2}\right) \right]$$
$$= -Z_1 \sum_{x \in I_R} \left(I_R(x) - I_T(h_\theta(x))\right)^2$$
$$= D_{SSD}[I_R, I_T, h_\theta]$$

- The sum of squared differences implements an independence assumption
- The parameter σ^2 becomes a weighting constant.

Likelihood from other metrics

• We can use any standard image metric $D[I_R, I_T, h_{\theta}]$ to define a likelihood function:

$$p(I_T|\theta, I_R) = \frac{1}{Z} \exp \left[-(D[I_R, I_T, h_\theta])\right]$$

- Examples:
 - Normalized cross correlations
 - Mutual information
 - ...
- Makes it possible to reformulate any standard registration problem into the analysis by synthesis framework.
- Special case of collective likelihood

What about surface registration?



Reference (surface): Γ_R

Target (surface): Γ_T

A trick: Implicit definition of a surface

- Any surface Γ can be represented as the zero level set of a level set function Φ

 $\Gamma = \{x \mid \Phi(x) = 0\}$

• Popular choice is the signed distance function defined as

$$D_{\Gamma}(x) = \|CP_{\Gamma}(x) - x\|$$

with
$$CP_{\Gamma}(x) = \arg\min_{x' \in \Gamma} \|x - x'\|$$



Surface registration as image registration

- We define the distance functions and use image to image likelihoods $p(D_T(h_\theta(x)) | \vec{\theta}, D_R, x) \sim N(D_R(x), \sigma^2)$
- Most likely solution will map points on the zero level-sets to each other
 - Noise parameter σ^2 has geometric interpretation (variance of distance between the mapped points)



Reference $D_R: \Omega_R \to \mathbb{R}$

Target $D_T : \Omega_T \to \mathbb{R}$

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Active shape models (surface to image registration)



- ASMs model each profile as a normal distribution $p(\rho_i) = N(\mu_i, \Sigma_i)$
- Single profile point x_i : $p(I_T(h_{\theta}(x_i))|\theta, x_i) = N(\mu_i, \Sigma_i)$
- Image likelihood:

$$p(I_T(h_{\theta}(x))|\theta, \Gamma_R) = \prod_i N(\mu_i, \Sigma_i)$$

Summary: Likelihood functions

- Synthesis function is often just a warp of a reference
 - Works well if modality and dimensionality is the same
 - Leads to very simple systems
- We get probabilistic interpretations of some standard metrics
 - Makes assumptions more clear

• If we do not want full interpretation any metric can be turned into a likelihood function

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- Advancing registration
 - More expressive priors
 - Hybrid registration
 - ASM using the Metropolis Hastings algorithm

Constructing s.p.d. kernels

1.
$$k(x, x') = f(x) f(x')^T, f: X \to \mathbb{R}^d$$

2. $k(x, x') = \alpha k(x, x'), \alpha \in \mathbb{R}_+$ (scaling)
3. $k(x, x') = B^T k(x, x') B, B \in \mathbb{R}^{r \times d}$ (lifting)
4. $k(x, x') = k_1(x, x') + k_2(x, x')$ (or relationship)
5. $k(x, x') = k_1(x, x') \cdot k_2(x, x')$ (and relationship)
6. $k(x, x') = k(\phi(x), \phi(x'))$ (domain warp)

Multi-scale kernels

Add kernels that act on different scales:

$$k(x,x') = \sum_{i=0}^{n} \sum_{k \in \mathbb{Z}^d} \beta (2^{-i}x - k) \beta (2^{-i}y - k)$$

Opfer, Roland. "Multiscale kernels." *Advances in computational mathematics* 25.4 (2006): 357-380.

Multi-scale kernel



Anisotropic priors

Scale deformations differently in each direction

$$k(x, x') = R^T \begin{pmatrix} \sqrt{s_1} & 0\\ 0 & \sqrt{s_2} \end{pmatrix} k(x, x') \begin{pmatrix} \sqrt{s_1} & 0\\ 0 & \sqrt{s_2} \end{pmatrix} R$$

- R is a rotation matrix
- k is scalar valued
- s_1 , s_2 scaling factors

Anisotropic priors



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Spatially-varying priors

Use different models for different regions

 $k(x, x') = \chi(x)\chi(x')k_1(x, x') + (1 - \chi(x))(1 - \chi(x'))k_2(x, x')$

 $\chi(x) = \begin{cases} 1 & \text{if } x \in \text{thumb region} \\ 0 & \text{otherwise} \end{cases}$



Freiman, Moti, Stephan D. Voss, and Simon K. Warfield. "Demons registration with local affine adaptive regularization: application to registration of abdominal structures." *Biomedical Imaging: From Nano to Macro, 2011 IEEE International Symposium on*. IEEE, 2011.

Spatially-varying priors



Landmark registration using Gaussian processes

The posterior $u \mid \tilde{x}_1, ..., \tilde{x}_m, \tilde{u}_1, ..., \tilde{u}_m$ is a Gaussian process $GP(\mu_p, k_p)$ Its parameters are known analytically.

 $\mu_p(x) = \mu(x) + K(x, Y)(K(Y, Y) + \sigma^2 I_{2m \times 2m})^{-1}(\widetilde{u} - \mu(Y))$ $k_p(x, x') = k(x, x') - K(x, Y)(K(Y, Y) + \sigma^2 I_{2m \times 2m})^{-1}K(Y, x')$

Landmark registration





Hybrid registration

- We can now combine landmark registration with intensity:
 - 1. Compute a posterior model using landmarks $GP(\mu, k)$
 - 2. Use $GP(\mu_p, k_p)$ as prior for registration with any image likelihood you like
- Example of Bayesian inference:

$$p(u) \rightarrow p(u|L_R, L_T) \rightarrow p(u|L_R, L_T, I_R, I_T)$$

• Elegant solution to hybrid registration

Wörz, Stefan, and Karl Rohr. "Hybrid spline-based elastic image registration using analytic solutions of the navier equation." *Bildverarbeitung für die Medizin 2007*. Springer Berlin Heidelberg, 2007. 151-155.

Lu, Huanxiang, Philippe C. Cattin, and Mauricio Reyes. "A hybrid multimodal non-rigid registration of MR images based on diffeomorphic demons." *Engineering in Medicine and Biology Society (EMBC), 2010 Annual International Conference of the IEEE*. IEEE, 2010.

Use Metropolis-Hastings for registration



- Frees us from "tyranny of differentiability"
 - Easy to integrate contours
 - Let's us model effects such as outliers, artifacts, ... in principled ways
- Makes it possible to integrate results of bottom up proposals (landmark detectors)
- Let's us reason about uncertainty of a solution

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Call to arms

- Our MCMC scheme was designed for really difficult problems
 - 3D => 2D
 - Complex illumination
 - No scale
 - Uncontrolled environment
- Let's start together to tackle the complicated problems in medical image analysis.



Call to arms

- Our MCMC scheme was designed for really difficult problems
 - 3D => 2D
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No ve you know how!

• Let's start together to tackle the complicated problems in medical image analysis